

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/584,142	LEE ET AL.	
	Examiner Shick C. Hom	Art Unit 2666	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
370	349, 389,	1/8/2006	SH
370	392, 393,	1/8/2006	SH
370	410,	1/8/2006	SH
370/395.1, 395.2, 395.6, 395.61, 395.64, 395.3, 395.31		1/8/2006	SH

Search Notes (continued)	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/584,142	LEE ET AL.
Examiner	Art Unit	
Shick C. Hom	2666	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
709	225, 227,	1/8/2006	SH
709	228, 230	1/8/2006	SH